

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/080,923	ORTHLIEB ET AL.	
Examiner	Art Unit	
Christopher A. Revak	2131	

Christopher A. Revak

SEARCHED			
Class	Subclass	Date	Examiner
none	none	12/14/2006	CR
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
726	2,21,26	12/14/2006	CR
726	27,30	12/14/2006	CR
705	50,51	12/14/2006	CR
705/	55-59	12/14/2006	CR

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
BRS Text Search USPAT, US PGPUB, USOCR, FPRS, DERWENT, IBM TDB, JPO, EPO (see attached strategy)	12/14/2006	CR
DIALOG Text Search COMPSCI, ELECTRON, SOFTWARE (see attached strategy)	12/14/2006	CR
Interference Search (see attached strategy)	12/14/2006	CR
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Search	Notes	(continued)

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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
705	500,530	12/14/2006	CR
705	531,533	12/14/2006	CR

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
n/a		
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